# **HEF4030B**

# Quad 2-input EXCLUSIVE-OR gate Rev. 4 — 13 November 2013

**Product data sheet** 

#### 1. **General description**

The HEF4030B is a quad 2-input EXCLUSIVE-OR gate. The outputs are fully buffered for the highest noise immunity and pattern insensitivity to output impedance.

It operates over a recommended  $V_{DD}$  power supply range of 3 V to 15 V referenced to  $V_{SS}$ (usually ground). Unused inputs must be connected to  $V_{DD},\,V_{SS},\,$  or another input.

#### Features and benefits 2.

- Fully static operation
- 5 V, 10 V, and 15 V parametric ratings
- Standardized symmetrical output characteristics
- Specified from -40 °C to +125 °C
- Complies with JEDEC standard JESD 13-B
- Inputs and outputs are protected against electrostatic effects

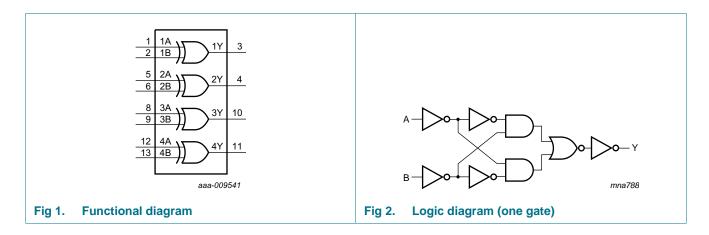
#### 3. Ordering information

Table 1. **Ordering information** 

All types operate from −40 °C to +125 °C

Type number	Package		
	Name	Description	Version
HEF4030BP	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1
HEF4030BT	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1

### **Functional diagram**

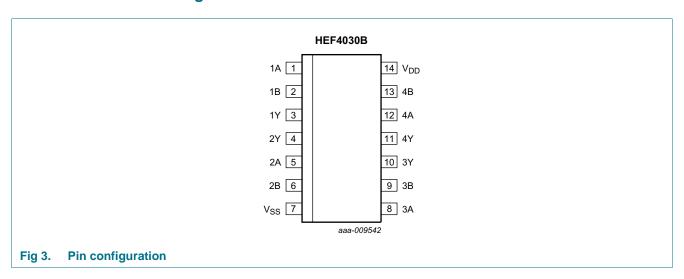




### **Quad 2-input EXCLUSIVE-OR gate**

### 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1A, 2A, 3A, 4A	1, 5, 8, 12	data input
1B, 2B, 3B, 4B	2, 6, 9, 13	data input
1Y, 2Y, 3Y, 4Y	3, 4, 10, 11	data output
$V_{SS}$	7	ground (0 V)
$V_{DD}$	14	supply voltage

# 6. Functional description

Table 3. Functional table[1]

Input	Output	
nA	nB	nY
L	L	L
L	Н	Н
Н	L	Н
Н	Н	L

<sup>[1]</sup> H = HIGH voltage level; L = LOW voltage level

### **Quad 2-input EXCLUSIVE-OR gate**

### 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to  $V_{SS} = 0 \text{ V}$  (ground).

Symbol	Parameter	Conditions	Min	Max	Unit		
$V_{DD}$	supply voltage		-0.5	+18	V		
I <sub>IK</sub>	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{DD} + 0.5 \text{ V}$	-	±10	mA		
VI	input voltage		-0.5	$V_{DD} + 0.5$	V		
lok	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{DD} + 0.5 \text{ V}$	-	±10	mA		
I <sub>I/O</sub>	input/output current		-	±10	mA		
I <sub>DD</sub>	supply current		-	50	mA		
T <sub>stg</sub>	storage temperature		-65	+150	°C		
T <sub>amb</sub>	ambient temperature		-40	+125	°C		
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to + } 125 ^{\circ}\text{C}$					
		DIP14	[1] -	750	mW		
		SO14	[2] _	500	mW		
Р	power dissipation	per output	-	100	mW		

<sup>[1]</sup> For DIP14 packages: above  $T_{amb}$  = 70 °C,  $P_{tot}$  derates linearly with 12 mW/K.

### 8. Recommended operating conditions

Table 5. Recommended operating conditions

Parameter	Conditions	Min	Тур	Max	Unit
supply voltage		3	-	15	V
input voltage		0	-	$V_{DD}$	V
ambient temperature	in free air	-40	-	+125	°C
input transition rise and fall rate	$V_{DD} = 5 V$	-	-	3.75	μs/V
	V <sub>DD</sub> = 10 V	-	-	0.5	μs/V
	V <sub>DD</sub> = 15 V	-	-	0.08	μs/V
	supply voltage input voltage ambient temperature	supply voltage input voltage ambient temperature in free air input transition rise and fall rate $V_{DD} = 5 \text{ V}$ $V_{DD} = 10 \text{ V}$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$

<sup>[2]</sup> For SO14 packages: above  $T_{amb}$  = 70 °C,  $P_{tot}$  derates linearly with 8 mW/K.

### Quad 2-input EXCLUSIVE-OR gate

### 9. Static characteristics

Table 6. Static characteristics

 $V_{SS} = 0$  V;  $V_I = V_{SS}$  or  $V_{DD}$ ; unless otherwise specified.

Symbol	Parameter	Conditions	$V_{DD}$	T <sub>amb</sub> =	-40 °C	T <sub>amb</sub> =	+25 °C	T <sub>amb</sub> =	+85 °C	T <sub>amb</sub> = ·	+125 °C	Unit
				Min	Max	Min	Max	Min	Max	Min	Max	
$V_{IH}$	HIGH-level	$ I_O  < 1 \mu A$	5 V	3.5	-	3.5	-	3.5	-	3.5	-	V
	input voltage		10 V	7.0	-	7.0	-	7.0	-	7.0	-	V
			15 V	11.0	-	11.0	-	11.0	-	11.0	-	V
$V_{IL}$	LOW-level	$ I_O  < 1 \mu A$	5 V	-	1.5	-	1.5	-	1.5	-	1.5	V
	input voltage		10 V	-	3.0	-	3.0	-	3.0	-	3.0	V
			15 V	-	4.0	-	4.0	-	4.0	-	4.0	V
$V_{OH}$	HIGH-level	$ I_O  < 1 \mu A$	5 V	4.95	-	4.95	-	4.95	-	4.95	-	V
	output voltage		10 V	9.95	-	9.95	-	9.95	-	9.95	-	V
			15 V	14.95	-	14.95	-	14.95	-	14.95	-	V
$V_{OL}$	LOW-level	$ I_O  < 1 \mu A$	5 V	-	0.05	-	0.05	-	0.05	-	0.05	V
	output voltage		10 V	-	0.05	-	0.05	-	0.05	-	0.05	V
			15 V	-	0.05	-	0.05	-	0.05	-	0.05	V
I <sub>OH</sub>	HIGH-level	$V_0 = 2.5 \text{ V}$	5 V	-	-1.7	-	-1.4	-	-1.1	-	-1.1	mΑ
	output current	V <sub>O</sub> = 4.6 V	5 V	-	-0.64	-	-0.5	-	-0.36	-	-0.36	mΑ
		V <sub>O</sub> = 9.5 V	10 V	-	-1.6	-	-1.3	-	-0.9	-	-0.9	mΑ
		V <sub>O</sub> = 13.5 V	15 V	-	-4.2	-	-3.4	-	-2.4	-	-2.4	mΑ
I <sub>OL</sub>	LOW-level	$V_0 = 0.4 \ V$	5 V	0.64	-	0.5	-	0.36	-	0.36	-	mΑ
	output current	V <sub>O</sub> = 0.5 V	10 V	1.6	-	1.3	-	0.9	-	0.9	-	mΑ
		V <sub>O</sub> = 1.5 V	15 V	4.2	-	3.4	-	2.4	-	2.4	-	mΑ
l <sub>l</sub>	input leakage current		15 V	-	±0.1	-	±0.1	-	±1.0	-	±1.0	μΑ
I <sub>DD</sub>	supply current	all valid input	5 V	-	0.25	-	0.25	-	7.5	-	7.5	μΑ
		combinations; $I_O = 0 A$	10 V	-	0.5	-	0.5	-	15.0	-	15.0	μΑ
			15 V	-	1.0	-	1.0	-	30.0	-	30.0	μΑ
Cı	input capacitance			-	-	-	7.5	-	-	-	-	pF

### **Quad 2-input EXCLUSIVE-OR gate**

### 10. Dynamic characteristics

Table 7. Dynamic characteristics

 $T_{amb}$  = 25 °C; for waveforms see Figure 4; for test circuit, see Figure 5; unless otherwise specified.

Symbol	Parameter	Extrapolation formula[1]	$V_{DD}$	Min	Тур	Max	Unit
t <sub>PHL</sub>	HIGH to LOW propagation delay	$57 + 0.55 \times C_{L}$	5 V	-	85	175	ns
		$24 + 0.23 \times C_L$	10 V	-	35	75	ns
		22 + 0.16 × C <sub>L</sub>	15 V	-	30	55	ns
t <sub>PLH</sub>	LOW to HIGH propagation delay	$47 + 0.55 \times C_{L}$	5 V	-	75	150	ns
	19 + 0.23 × C <sub>L</sub>	10 V	-	30	65	ns	
		17 + 0.16 × C <sub>L</sub>	15 V	-	25	50	ns
t <sub>THL</sub>	HIGH to LOW output transition time	10 + 1.00 × C <sub>L</sub>	5 V	-	60	120	ns
		9 + 0.42 × C <sub>L</sub>	10 V	-	30	60	ns
		6 + 0.28 × C <sub>L</sub>	15 V	-	20	40	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	10 + 1.00 × C <sub>L</sub>	5 V	-	60	120	ns
		$9 + 0.42 \times C_L$ 10 V - 30		60	ns		
		6 + 0.28 × C <sub>L</sub>	15 V	-	20	40	ns

<sup>[1]</sup> The typical value of the propagation delay and output transition time can be calculated with the extrapolation formula (C<sub>L</sub> in pF).

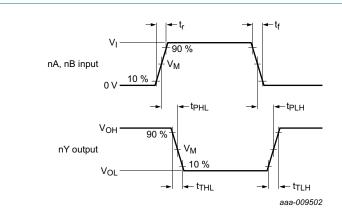
Table 8. Dynamic power dissipation

 $V_{SS} = 0 \ V; \ t_f = t_f \le 20 \ ns; \ T_{amb} = 25 \ ^{\circ}C.$ 

Symbol	Parameter	$V_{DD}$	Typical formula	Where
$P_{D}$	dynamic power dissipation	5 V	$P_D = 1100 \times f_i + \Sigma (f_o \times C_L) \times V_{DD}^2 (\mu W)$	$f_i$ = input frequency in MHz;
		10 V	$P_D = 4900 \times f_i + \Sigma (f_0 \times C_L) \times V_{DD}^2 (\mu W)$	f <sub>o</sub> = output frequency in MHz;
		15 V	$P_D = 14400 \times f_i + \Sigma (f_0 \times C_L) \times V_{DD}^2 (\mu W)$	$C_L$ = output load capacitance in pF;
				$\Sigma(f_0 \times C_L)$ = sum of the outputs;
				V <sub>DD</sub> = supply voltage in V.

### **Quad 2-input EXCLUSIVE-OR gate**

### 11. Waveforms



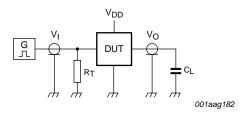
Measurement points are given in Table 9.

Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

Fig 4. Input to output propagation delays and output transition times

Table 9. Measurement points

Supply voltage	Input	Output
$V_{DD}$	V <sub>M</sub>	V <sub>M</sub>
5 V to 15 V	0.5V <sub>DD</sub>	0.5V <sub>DD</sub>



Test data is given in  $\underline{\text{Table 10}}$ .

Definitions for test circuit:

DUT = Device Under Test.

 $C_L$  = load capacitance including jig and probe capacitance.

 $R_T$  = termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

Fig 5. Test circuit for measuring switching times

Table 10. Test data

Supply voltage	Input				
$V_{DD}$	VI	t <sub>r</sub> , t <sub>f</sub>	CL		
5 V to 15 V	V <sub>SS</sub> or V <sub>DD</sub>	≤ 20 ns	50 pF		

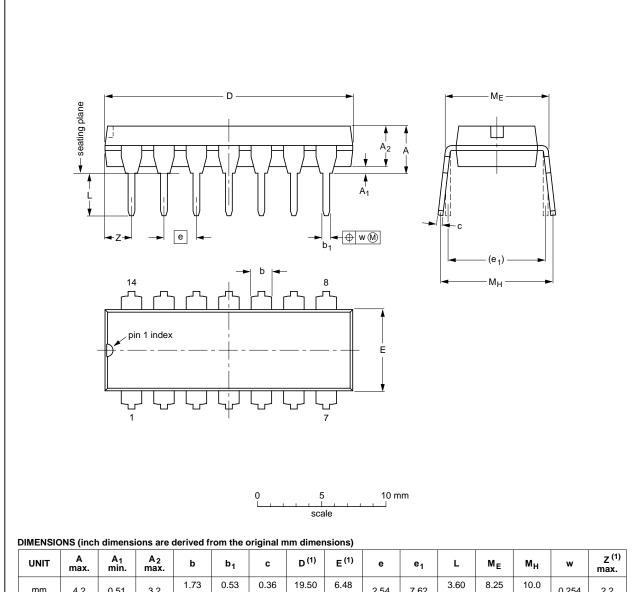
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### **Quad 2-input EXCLUSIVE-OR gate**

### 12. Package outline

### DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.02	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

#### Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

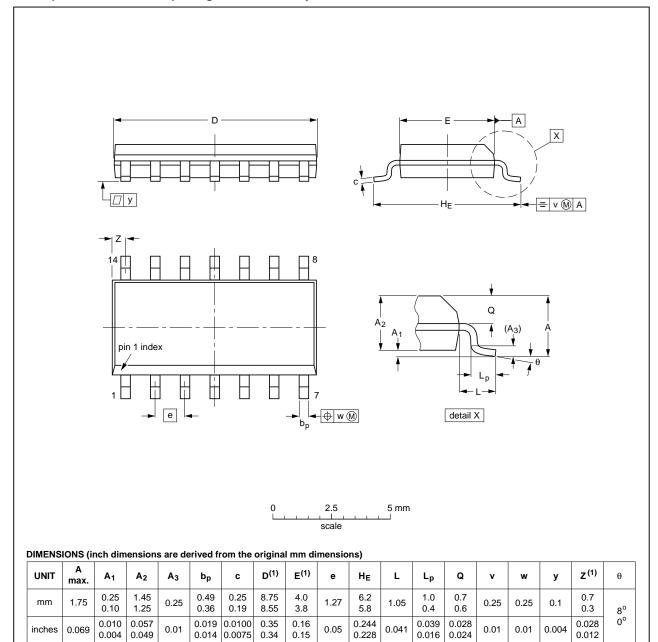
OUTLINE		REFER	ENCES		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001	SC-501-14			<del>99-12-27</del> 03-02-13

Package outline SOT27-1 (DIP14) Fig 6.

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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012				<del>99-12-27</del> 03-02-19

Fig 7. Package outline SOT108-1 (SO14)

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### **Quad 2-input EXCLUSIVE-OR gate**

### 13. Abbreviations

### Table 11. Abbreviations

Acronym	Description
DUT	Device Under Test

# 14. Revision history

### Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
HEF4030B v.4	20131113	Product data sheet	-	HEF4030B_CNV v.3
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>			rith the new identity
	<ul> <li>Legal texts</li> </ul>	have been adapted to the r	ew company name whe	re appropriate.
	<ul> <li>Changes in</li> </ul>	"General description" and '	Features and benefits".	
HEF4030B_CNV v.3	19950101	Product specification	-	-

#### **Quad 2-input EXCLUSIVE-OR gate**

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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### **Quad 2-input EXCLUSIVE-OR gate**

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